

ET-AL: Entropy Targeted Active Learning for Materials Data Bias Mitigation

Henry Zhang¹, Wayne Chen¹, James Rondinelli², Wei Chen¹ ¹Mechanical Engineering, Northwestern University ²Materials Science & Engineering, Northwestern University





Integrated DEsign Automation Laboratory

Materials Informatics, Data, and Bias



H. Zhang et al. ET-AL: Entropy Targeted Active Learning for Materials Data Bias Mitigation. In preparation.

Lower Bias, Better ML Models



Reducing bias benefits ML for materials properties





Experiments for demonstration on Jarvis dataset

Applications

- Improve dataset quality
- Guide the construction of databases

CHMaD

Thank you & welcome to our poster!

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